



ALPHA & OMEGA
SEMICONDUCTOR, LTD



AO4617

Complementary Enhancement Mode Field Effect Transistor

General Description

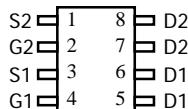
The AO4617 uses advanced trench technology MOSFETs to provide excellent $R_{DS(ON)}$ and low gate charge. The complementary MOSFETs may be used in H-bridge, Inverters and other applications. Standard Product AO4617 is Pb-free (meets ROHS & Sony 259 specifications). AO4617L is a Green Product ordering option. AO4617 and AO4617L are electrically identical.

Features

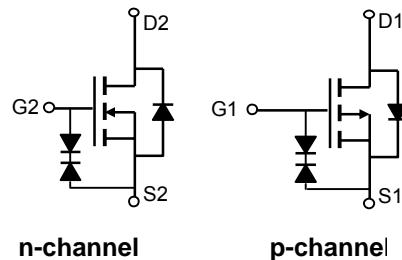
| | |
|-----------------------------|----------------------------|
| n-channel | p-channel |
| V_{DS} (V) = 40V | -40V |
| I_D = 6A (V_{GS} =10V) | -5A (V_{GS} = -10V) |
| $R_{DS(ON)}$ | $R_{DS(ON)}$ |
| < 32mΩ (V_{GS} =10V) | < 48mΩ (V_{GS} = -10V) |
| < 45mΩ (V_{GS} =4.5V) | < 75mΩ (V_{GS} = -4.5V) |
| ESD rating: 3000V (HBM) | |

UIS TESTED!

Rg,Ciss,Coss,Crss Tested



SOIC-8



n-channel

p-channel

Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Max n-channel | Max p-channel | Units |
|--|----------------|---------------|---------------|-------|
| Drain-Source Voltage | V_{DS} | 40 | -40 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | ± 20 | V |
| Continuous Drain Current ^A | I_D | 6 | -5 | A |
| $T_A=70^\circ\text{C}$ | | 5 | -4 | |
| Pulsed Drain Current ^B | I_{DM} | 30 | -25 | |
| Power Dissipation | P_D | 2 | 2 | W |
| $T_A=70^\circ\text{C}$ | | 1.28 | 1.28 | |
| Avalanche Current ^B | I_{AR} | 13 | 17 | A |
| Repetitive avalanche energy 0.3mH ^B | E_{AR} | 25 | 43 | mJ |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 150 | -55 to 150 | °C |

Thermal Characteristics: n-channel and p-channel

| Parameter | Symbol | Device | Typ | Max | Units |
|--|-----------------|--------|-----|------|-------|
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | n-ch | 48 | 62.5 | °C/W |
| Steady-State | | n-ch | 74 | 110 | °C/W |
| Maximum Junction-to-Lead ^C | $R_{\theta JL}$ | n-ch | 35 | 50 | °C/W |
| Steady-State | | p-ch | 48 | 62.5 | °C/W |
| Maximum Junction-to-Ambient ^A | $R_{\theta JA}$ | p-ch | 74 | 110 | °C/W |
| Steady-State | | p-ch | 35 | 50 | °C/W |

N Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|-----|------|---------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | 40 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=32\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | 1 | μA |
| | | | | | 5 | |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS} = \pm 20\text{V}$ | | | ± 1 | mA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$ | 1 | 2.2 | 3 | V |
| $I_{\text{D(ON)}}$ | On state drain current | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$ | 30 | | | A |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=10\text{V}, I_D=6\text{A}$ $T_J=125^\circ\text{C}$ | | 26 | 32 | $\text{m}\Omega$ |
| | | | | 39 | 48 | |
| | | $V_{GS}=4.5\text{V}, I_D=5\text{A}$ | | 36 | 45 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=5\text{V}, I_D=6\text{A}$ | | 18 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=1\text{A}, V_{GS}=0\text{V}$ | | 0.76 | 1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 3 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=20\text{V}, f=1\text{MHz}$ | | 506 | | pF |
| C_{oss} | Output Capacitance | | | 106 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 38 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 2.6 | 3.9 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge | $V_{GS}=10\text{V}, V_{DS}=20\text{V}, I_D=6\text{A}$ | | 8.4 | | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge | | | 4.1 | | nC |
| Q_{gs} | Gate Source Charge | | | 1.6 | | nC |
| Q_{gd} | Gate Drain Charge | | | 2.7 | | nC |
| $t_{\text{D(on)}}$ | Turn-On DelayTime | $V_{GS}=10\text{V}, V_{DS}=20\text{V}, R_L=3.3\Omega, R_{\text{GEN}}=3\Omega$ | | 4.8 | | ns |
| t_r | Turn-On Rise Time | | | 2 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off DelayTime | | | 17 | | ns |
| t_f | Turn-Off Fall Time | | | 2.1 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | $I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 17.4 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=6\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 10.9 | | nC |

A: The value of R_{QJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R_{QJA} is the sum of the thermal impedance from junction to lead R_{QJL} and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

Rev 0 : October 2006

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL

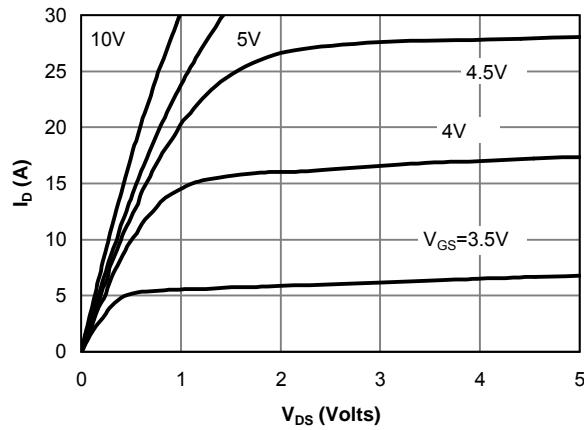


Figure 1: On-Region Characteristics

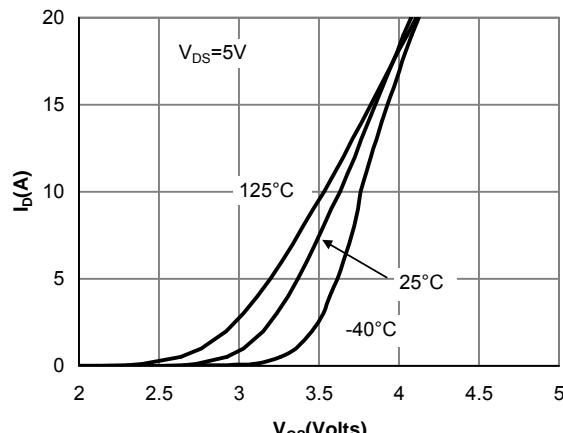


Figure 2: Transfer Characteristics

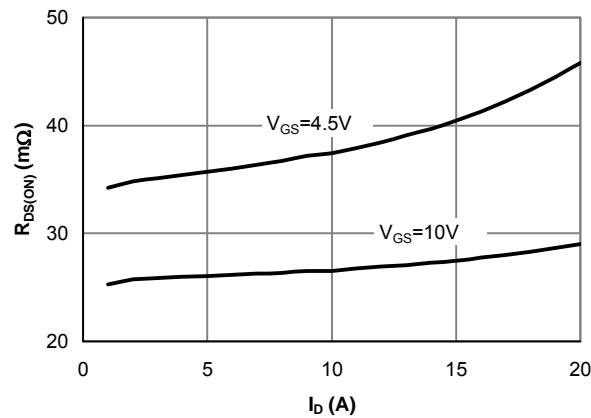


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

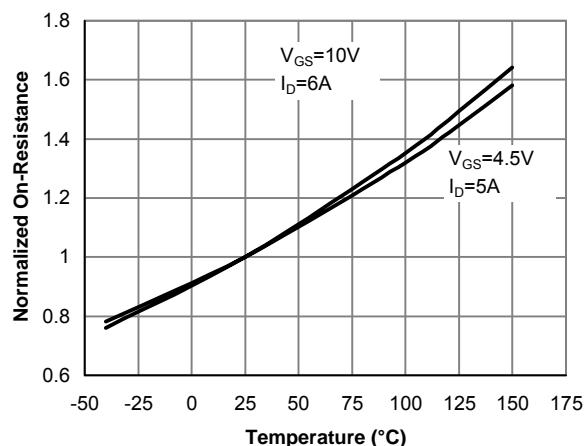


Figure 4: On-Resistance vs. Junction Temperature

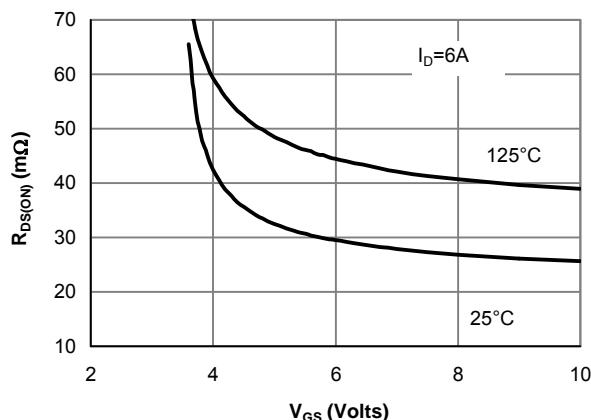


Figure 5: On-Resistance vs. Gate-Source Voltage

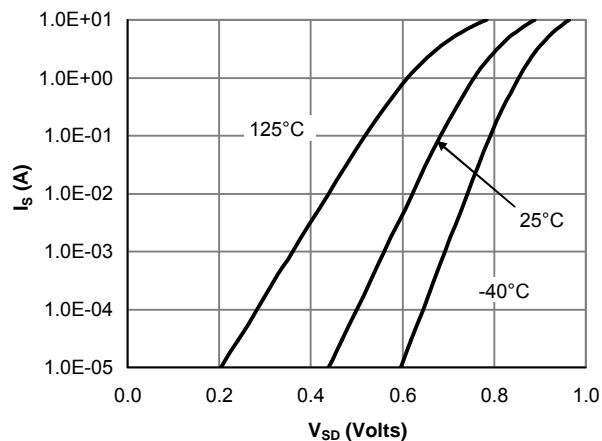


Figure 6: Body-Diode Characteristics

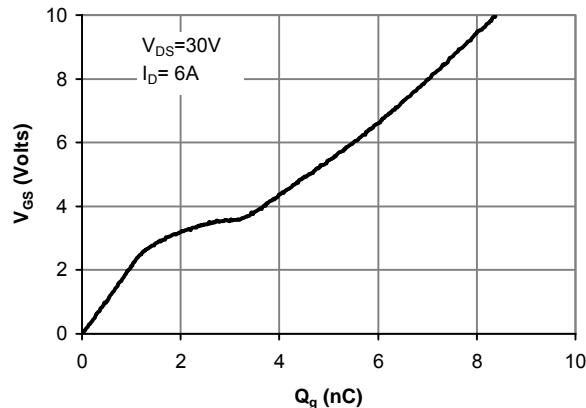
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: N-CHANNEL


Figure 7: Gate-Charge Characteristics

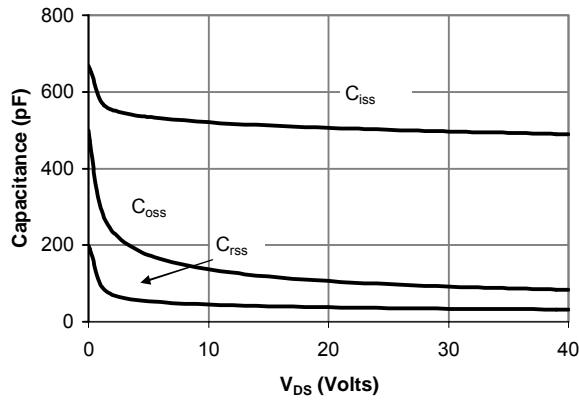


Figure 8: Capacitance Characteristics

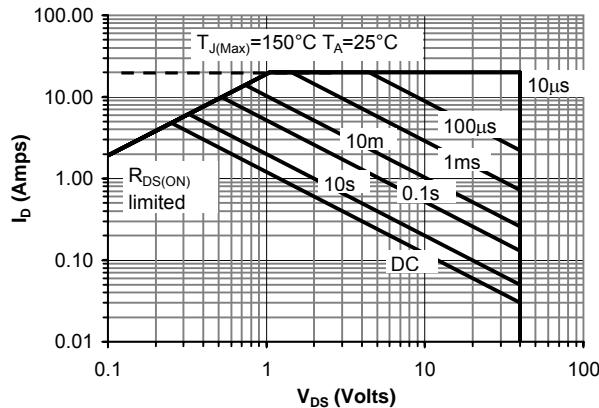


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

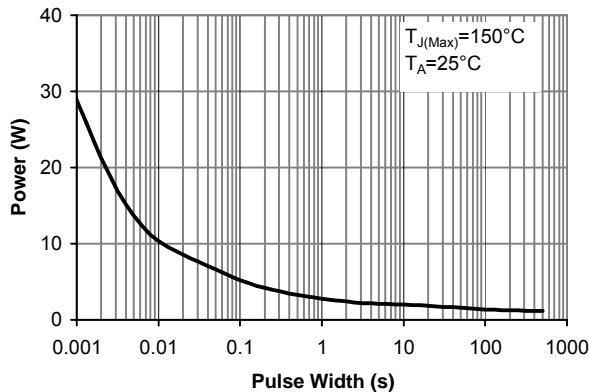


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

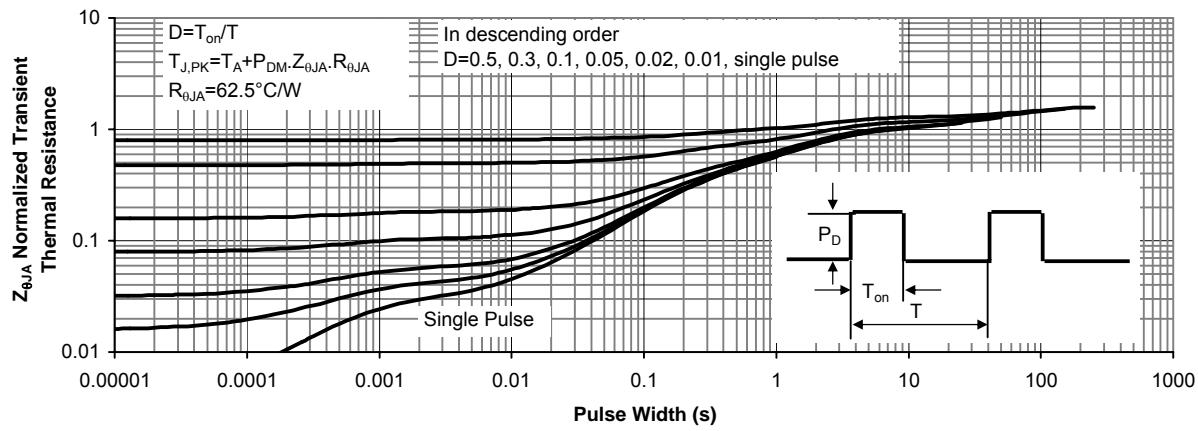


Figure 11: Normalized Maximum Transient Thermal Impedance

P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|---------------------------------------|---|---|----------|----------|------------------|
| STATIC PARAMETERS | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$ | -40 | | | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-32\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$ | | | -1 -5 | μA |
| I_{GSS} | Gate-Body leakage current | $V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$ | | | ±150 | μA |
| $V_{\text{GS(th)}}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ | -1 | -2 | -3 | V |
| $I_{\text{D(ON)}}$ | On state drain current | $V_{GS}=-10\text{V}, V_{DS}=-5\text{V}$ | -25 | | | A |
| $R_{\text{DS(ON)}}$ | Static Drain-Source On-Resistance | $V_{GS}=-10\text{V}, I_D=-5\text{A}$ $T_J=125^\circ\text{C}$ | | 40 56 | 48 68 | $\text{m}\Omega$ |
| | | $V_{GS}=-4.5\text{V}, I_D=-4\text{A}$ | | 61 | 75 | $\text{m}\Omega$ |
| g_{FS} | Forward Transconductance | $V_{DS}=-5\text{V}, I_D=-5\text{A}$ | | 11 | | S |
| V_{SD} | Diode Forward Voltage | $I_S=-1\text{A}, V_{GS}=0\text{V}$ | | -0.76 | -1 | V |
| I_S | Maximum Body-Diode Continuous Current | | | | 3.5 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C_{iss} | Input Capacitance | $V_{GS}=0\text{V}, V_{DS}=-20\text{V}, f=1\text{MHz}$ | | 1006 | | pF |
| C_{oss} | Output Capacitance | | | 152 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 77 | | pF |
| R_g | Gate resistance | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$ | | 11 | | Ω |
| SWITCHING PARAMETERS | | | | | | |
| $Q_g(10\text{V})$ | Total Gate Charge (10V) | $V_{GS}=-10\text{V}, V_{DS}=-20\text{V}, I_D=-5\text{A}$ | | 17.4 | | nC |
| $Q_g(4.5\text{V})$ | Total Gate Charge (4.5V) | | | 8.9 | | nC |
| Q_{gs} | Gate Source Charge | | | 3.1 | | nC |
| Q_{gd} | Gate Drain Charge | | | 4.6 | | nC |
| $t_{\text{D(on)}}$ | Turn-On DelayTime | $V_{GS}=-10\text{V}, V_{DS}=-20\text{V}, R_L=4\Omega, R_{\text{GEN}}=3\Omega$ | | 9.7 | | ns |
| t_r | Turn-On Rise Time | | | 6.3 | | ns |
| $t_{\text{D(off)}}$ | Turn-Off DelayTime | | | 35.5 | | ns |
| t_f | Turn-Off Fall Time | | | 26 | | ns |
| t_{rr} | Body Diode Reverse Recovery Time | | $I_F=-5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | 21.8 | | ns |
| Q_{rr} | Body Diode Reverse Recovery Charge | $I_F=-5\text{A}, dI/dt=100\text{A}/\mu\text{s}$ | | 15.5 | | nC |

A: The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $\leq 10\text{s}$ thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to lead $R_{\theta JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using <300μs pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

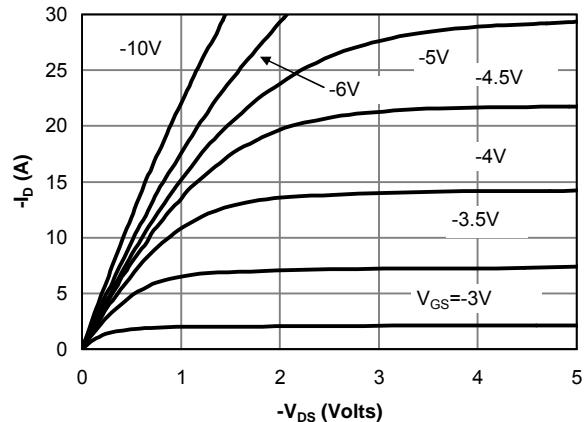


Fig 1: On-Region Characteristics

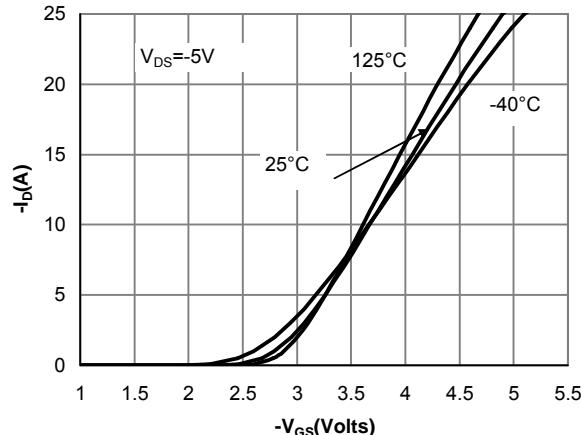


Figure 2: Transfer Characteristics

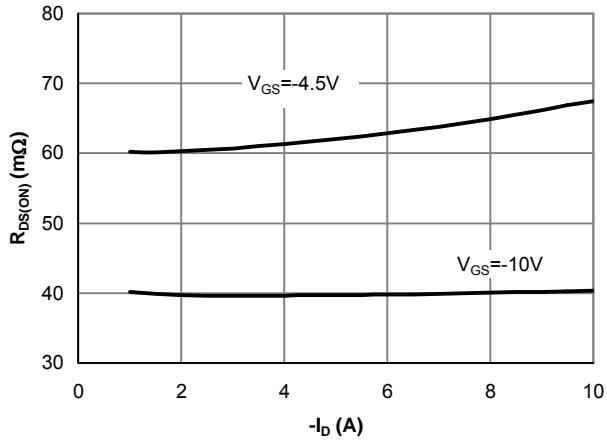


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

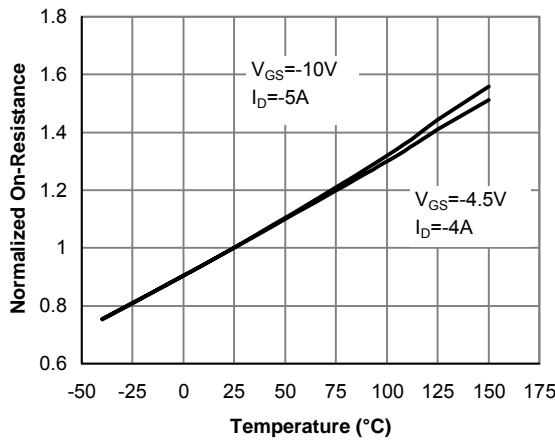


Figure 4: On-Resistance vs. Junction Temperature

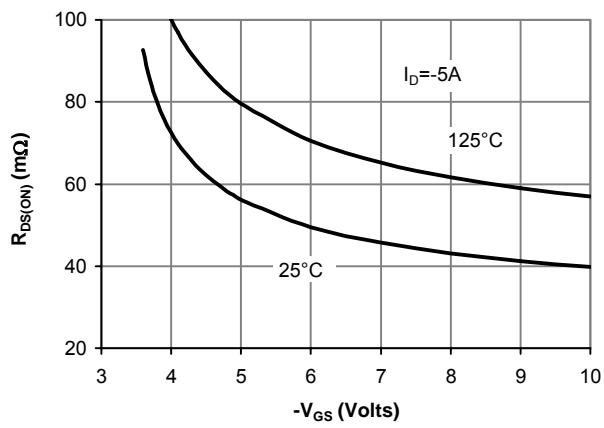


Figure 5: On-Resistance vs. Gate-Source Voltage

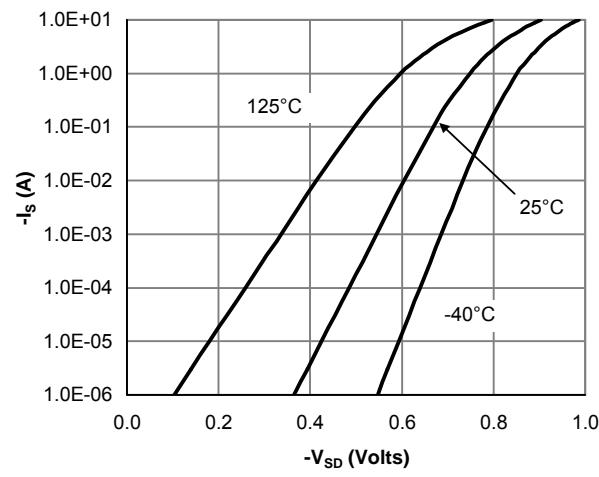


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS: P-CHANNEL

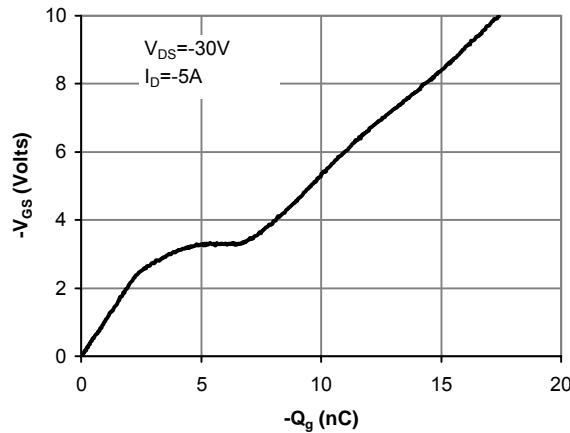


Figure 7: Gate-Charge Characteristics

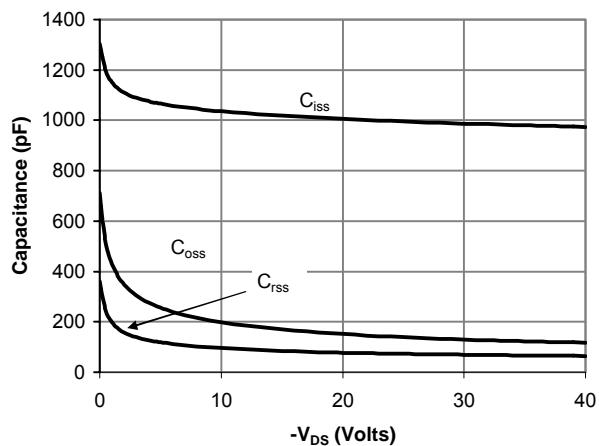


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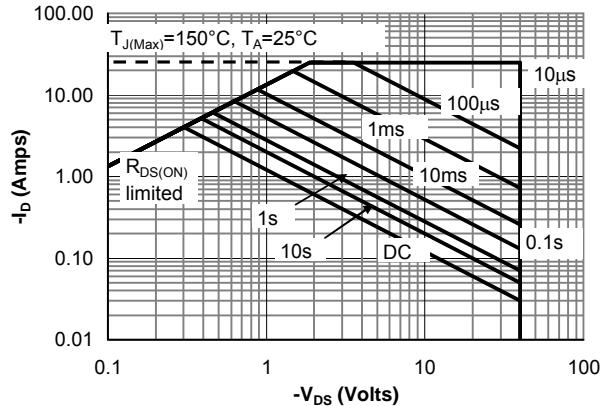


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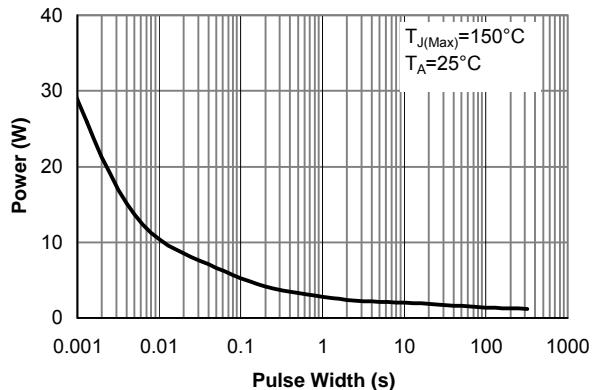


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

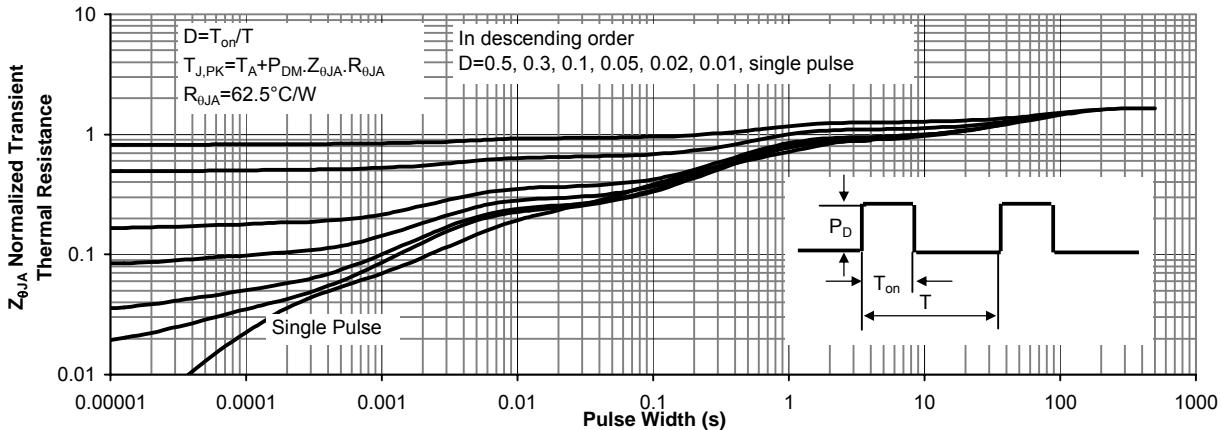


Figure 11: Normalized Maximum Transient Thermal Impedance (Note E)